## Electronic Supplemental Information

## Part 1 - Angular cross-correlation



SI-1: Definition of the angular cross-correlation. ${ }^{\Phi}$ denotes the azimuthal angle and $\Delta$ the angle between two points on a scattering intensity annulus.

Fig. SI-1 shows a typical two-dimensional scattering pattern. The definition of the angular cross-correlation function for such a pattern at fixed wave vector transfer $Q$ is [1,2]:
$C(Q, \Delta)=\frac{\langle I(Q, \Phi) I(Q, \Phi+\Delta)\rangle_{\Phi}-\langle I(Q, \Phi)\rangle_{\Phi}^{2}}{\langle I(Q, \Phi)\rangle_{\Phi}^{2}}$.

Herein, $\Delta$ denotes the angle between two points on an intensity annulus $I(Q)$ with radius $Q$. For these the cross-correlation is computed by taking the product of all points at given angle $\Phi$ on the annulus that are separated by $\Delta .\langle\cdot\rangle_{\Phi}$ denotes the angular average over such an annulus.

## Part 2 - Superlattice structures $A B_{2}$ and $A B_{13}$



SI-2 - $A B_{2}$ structure and $A B_{13}$ structure.

Binary mixtures of colloids can form crystals with superlattice structures. Common superlattice structures are the $\mathrm{AB}_{2}$ and $\mathrm{AB}_{13}$ structures (Fig. $\mathrm{SI}-2$ ). ' A ' denotes the large particle species, ' $B$ ' the small one.

The hexagonal $A B_{2}$ structure consists of a hexagonal closed packing of large particles. The small particles form planar rings filling the holes between the larger particles [3].

In the $A B_{13}$ structure, the large particles form a simple cubic structure. Within this cube, a body-centered small particle is located which is surrounded by 12 other small particles in an icosahedral structure [3].

The stability of these superlattices depends on the radius ratio $\alpha$. For $0.425<\alpha<0.60$, the $A B_{2}$ structure is stable, and for $0.485<\alpha<0.62$, the $A B_{13}$ structure is stable [4]. As the radius ratio of the silica particles used was $\alpha=0.58$, both structure are expected to be present within the colloidal film.

## Part 3 - Results of a binary colloid film with $X=0.89$

In the following the scanning SAXS and XCCM results on a dried colloidal film with particle size ratio $\alpha=0.58$ and mixing ratio $X=0.89$ are presented. The experimental conditions were the same as described in the main part.

Part 3.1 - Intensity maps for $\boldsymbol{X}=\mathbf{0 . 8 9}$


SI-3 - Intensity map for $X=0.89, Q_{1}$.
Fig. SI-3 shows the scanning map of the scattering intensity of the $Q_{1}$ - partition. Clearly visible are the sharp edges of the dried colloidal film. The strongest scattering intensity is detected for a pronounced stripe in the upper part close to the edge of the film. In contrast, for the region below a continuous reduction of the scattering intensity is present. This points towards a particle density gradient in the film (indicated by the red arrow).


SI-4 - Intensity map for $X=0.89, Q_{2}$.
Compared to the $Q_{1}$ - partition, the scattering intensity of the $Q_{2}$ - partition (Fig. SI-4) is in general stronger because the small particle species is dominating within the sample. In contrast to the intensity map at $Q_{1}$, the intensity gradient is weaker in the film. This suggests that the large silica particles are mainly contained in the stripe-like region close to the upper film edge. The small particles are distributed everywhere in the film. Thus, for this sample particle segregation within the drying process took place.

## Part 3.2 - Cross-correlation maps for $X=0.89$

Figures $\mathrm{SI}-5$ to $\mathrm{SI}-10$ display the XCCM maps for $I=2,4$ and 6 for both $Q$-partitions. As for the $X=0.66$ sample, a strong $I=2$ contribution is present at the film edge at $Q_{1}$. For the other parts of this film, the $I=4$ contribution is stronger than the $I=2$ contribution. The region where the large particle species is more dominantly present, i.e. the stripe region, has a reduced four-fold order compared to the other parts of the sample. Notable is one ordered region containing only the large particles (Fig. SI-5 to $\mathrm{SI}-7$ in the upper right corner).


SI-6 - XCCM map $Q_{1}, I=4$.


SI-7 - XCCM map $Q_{1}, I=6$.


SI-8 - XCCM map $Q_{2}, I=2$.


SI-9 - XCCM map $Q_{2}, I=4$.


SI-10 - XCCM map $Q_{2}, I=6$.

Part 3.3 - Map sections for $\boldsymbol{X}=0.89$


SI-11 - Map section for $Q_{1}$.The / = 2 component, being only an indicator for the film edges, is not shown.


SI-12 - Map section for $Q_{2}$.

Fig. SI-11 and $\mathrm{SI}-12$ show the results of the sections of the intensity and XCCM maps for both $Q$-partitions along the red arrow (see Fig. SI-3) averaging along the full film size. For $Q_{1}$ the prounced stripe as well as the decreasing particle density are visbile from the intensity curve. In case of the cut for the $Q_{2}$ map, the scattering intensity is neither that strong at the stripe region nor is the particle gradient that strong indicating a more homogenous distribution of small particles.

For the $Q_{1}$-partition the I = 4 contribution is the most dominant Fourier component. It is reduced in the stripe-region indicating a reduced order due to the high fraction of large silica particles. The $I=4$ curve is nearly constant along the other part of the film for $Q_{1}$. The other Fourier components studied, i.e. $I=6-10$, have reduced amplitudes of similar values and show small maxima at both the stripe region and within the small particle region.

In contrast, for the $Q_{2}$ map the I = 2 Fourier component is the strongest component. It exhibits a minimum in the stripe region and is nearly constant within the other part of the film. The $I=4$ component has a smaller amplitude but a similar shape. The $I=6$ component is nearly constant. This finding is similar to that for the film with $X=0.66$.

## References

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